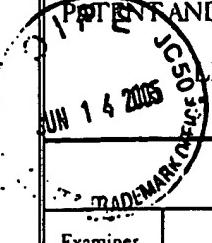


Form PTO-1449 <b>U.S. DEPARTMENT OF COMMERCE</b> <b>PATENT AND TRADEMARK OFFICE</b>  <b>LIST OF ART CITED BY APPLICANT</b> (Use several sheets if necessary)					ATTY. DOCKET NO. MI40-366	SERIAL NO. 10/759,976	
					APPLICANT Mark E. Tuttle		
					FILING DATE January 15, 2004	GROUP 2635	
U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
<i>BT</i>	AA	5,055,968	10/8/91	NISHI ET AL.	361	395	
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Clas s	Subcl ass	Translation
							Yes      No
	AK						
	AL						
	AM						
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
	AN						
	AO						
	AP						
EXAMINER	DATE CONSIDERED	<i>BT</i> 8/24/05					
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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				ATTY. DOCKET NO. M210-166	SERIAL NO. Filed Herewith		
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Mark E. Tuck			
				FILING DATE Filed Herewith	GROUP Unknown		
U.S. PATENT DOCUMENTS							
*Examiner Initials		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
<i>BG</i>	AA	5,113,184	03/12/97	Kazuyuki			
	AB	5,649,296	07/13/97	MacLellan et al.			
	AC	5,621,612	04/15/97	Sherpe et al.			
	AD	5,926,182	05/13/90	Ohta et al.			
	AE	4,075,632	02/24/78	Baldwin et al.			
	AF	3,703,714	11/21/72	Andrews			
	AG	4,242,671	12/30/80	Flows			
	AH	4,384,288	05/17/83	Wahon			
	AI	4,369,557	01/25/83	Vandebilt			
	AJ	4,501,938	02/26/85	Kawasaki			
	AK	4,509,093	04/02/85	Stelberger			
	AL	4,568,918	02/04/86	Edel			
	AM	6,940,245	07/10/90	Blank, R.			
	AN	5,019,801	05/28/91	Anderson, III			
	<i>BG</i>	AO	5,136,131	01/04/93	Komaki		
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation
<i>BG</i>	AP	DE 196 45 033	5/7/93	Germany			Yes
	AQ	EP 0 562 292	2/2/93	EPO			No
	AR						
	AS						
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)							
	AT	The New IEEE Standard Dictionary of Electrical and Electronics Terms - 5th Ed., ©1993, 1 pg. (120).					
	AU						
	AV						
EXAMINER	BRIAN ZIMMERMAN PRIMARY EXAMINER		DATE CONSIDERED		<i>4/26/05</i>		
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LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)					APPLICANT Mark E. Teale		
					FILING DATE Filed Herewith	GROUP Unknown	
U.S. PATENT DOCUMENTS							
*Examiner listed		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
<i>BB</i>	AA	5,299,237	01/29/94	Ross			
	AB	5,379,013	01/03/95	Ingi et al.			
	AC	5,448,119	09/05/95	Tuttle et al.			
	AD	5,852,269	12/02/98	Mashiko			
	AE	5,916,094	07/23/99	Macneu			
	AF	5,937,512	08/17/99	Latz			
	AG	5,942,978	02/24/99	Shuler			
	AH	5,963,177	10/05/99	Tuttle et al.			
	AI	5,972,152	10/26/99	Latz et al.			
	AJ	5,972,156	10/26/99	Brady et al.			
	AK	5,988,510	11/23/99	Tuttle et al.			
	AL	6,130,682-Jurzko	10/10/00	O'Toole et al.			
	AM	6,037,879	03/14/00	Tuttle			
	AN	5,525,992	06/11/96	Puschendorf			
<i>BB</i>	AO	4,518,425	04/1990	Grossberg et al.			
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation
	AP						Yes
	AQ						No
	AR						
	AS						
OTHER REFERENCES (including Author, Title, Date, Permanent Pages, etc.)							
	AT						
	AU						
	AV						
EXAMINER <b>BRIAN ZIMMERMAN</b> <b>PRIMARY EXAMINER</b>				DATE CONSIDERED <i>4/26/05</i>			
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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				ATTY. DOCKET NO. MHO-346	SERIAL NO. 5116166		
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Mark E. Teste			
				FILING DATE Filed Herewith	GROUP Unknown		
U.S. PATENT DOCUMENTS							
*Examiner Initials		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
<i>B6</i>	AA	5,319,364	06/1994	Watanabe et al.			
	AB	5,764,180	08/1998	Cronings			
	AC	5,917,423	06/1999	Dewall			
	AD	5,952,937	09/1999	Koopman et al.			
	AE	5,918,347	11/1999	Brahmeyer et al.			
	AF	6,285,295	09/2001	Costa			
<i>B6</i>	AG	6,380,845	04/2002	Turde			
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
	AO						
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translations
	AP						Yes
	AQ						No
	AR						
	AS						
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
	AT						
	AU						
	AV						
EXAMINER	BRIAN ZIMMERMAN <b>PRIMARY EXAMINER</b>			DATE CONSIDERED	<i>4/26/05</i>		
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							